

STGF10NB60SD

N-channel 10A - 600V - TO-220FP PowerMESH™ IGBT

General features

Туре	V _{CES}	V _{CE(sat)} (Max)@ 25°C	I _C @100°C
STGF10NB60SD	600V	<1.8V	7A

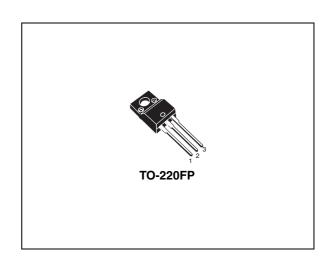
- Hight input impedance (voltage driven)
- Low on-voltage drop
- High current capability
- Co-packaged with turboswitch[™] antiparallel diode

Description

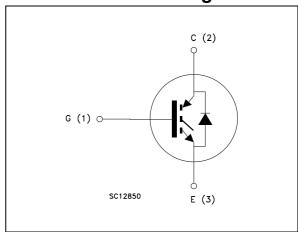
Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix "S" identifies a family optimized achieve minimum on-voltage drop for low frequency applications (<1kHz).

Applications

- Light dimmer
- Static relays
- Motor control



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STGF10NB60SD	GF10NB60SD	TO-220FP	Tube

Contents STGF10NB60SD

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STGF10NB60SD Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit	
V _{CES}	Collector-emitter voltage (V _{GS} = 0)	600	٧	
I _C	Collector current (continuous) at 25°C	20	Α	
I _C	Collector current (continuous) at 100°C	7	Α	
I _{CM} ⁽¹⁾	Collector current (pulsed)	100	Α	
V _{GE}	Gate-emitter voltage	± 20	V	
P _{TOT}	Total dissipation at T _C = 25°C	25	W	
V _{ISO}	Insulation withstand voltage A.C.(t = 1sec;Tc=25°C) 2500		V	
T _{stg}	Operating junction temperature	- 55 to 150		
T _j	Storage temperature	- 55 to 150		

^{1.} Pulse width limited by max. junction temperature.

Table 2. Thermal resistance

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case Max	5	°C/W
Rthj-amb	Thermal resistance junction-ambient Max	62.5	°C/W

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2 Electrical characteristics

(T_{CASE} =25°C unless otherwise specified)

Table 3. Static

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
V _{BR(CES)}	Collector-emitter breakdown voltage	$I_C = 250\mu A, V_{GE} = 0$	600			٧
V _{BR(CES)}	Collector-emitter breakdown voltage	I _C = 1mA, V _{GE} = 0	20			٧
V _{CE(SAT)}	Collector-emitter saturation voltage	V _{GE} =15V, I _C = 5A, Tj= 25°C V _{GE} =15V, I _C = 10A, Tj= 25°C V _{GE} =15V, I _C = 10A, Tj= 125°C		1.15 1.35 1.25	1.8	V V V
V _{GE(th)}	Gate threshold voltage	$V_{CE} = V_{GE}, I_{C} = 250 \mu A$	2.5		5	٧
I _{CES}	Collector-emitter leakage current (V _{CE} = 0)	V_{CE} = Max rating , T_j =25 °C V_{CE} = Max rating , T_j =125 °C			10 100	μA μA
I _{GES}	Gate-emitter leakage current (V _{CE} = 0)	$V_{GE} = \pm 20V$, $V_{CE} = 0$			±100	nA
9 _{fs}	Forward transconductance	V _{CE} = 25 V , I _C =10 A	5			S

Table 4. Dynamic

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
C _{ies} C _{oes} C _{res}	Input capacitance Output capacitance Reverse transfer capacitance	V _{CE} = 25V, f = 1 MHz, V _{GE} = 0		610 65 12		pF pF pF
Qg	Total gate charge	$V_{CE} = 400V, I_{C} = 10 A,$ $V_{GE} = 15V$		33		nC
I _{CL}	Turn-off SOA minimum current	V _{clamp} = 480V, RG= 1kΩ Tj= 125°C	20			Α

Table 5. Switching on/off (inductive load)

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
$t_{d(on)}$ t_{r} $(di/dt)_{on}$ E_{on} (1)	Turn-on delay time Current rise time Turn-on current slope Turn-on switching losses	$V_{CC} = 480 \text{ V}, I_{C} = 10 \text{ A}$ $R_{G} = 1K\Omega, V_{GE} = 15 \text{ V}$ $Tj = 25^{\circ}\text{C} \text{ (see Figure 15)}$		0.7 0.46 8 0.6		μs μs Α/μs mJ
$t_{r}(V_{off})$ $t_{d}(_{off})$ t_{f} $E_{off}^{(2)}$	Off voltage rise time Turn-off delay time Current fall time Turn-off switching losses	$V_{CC} = 480 \text{ V}, I_{C} = 10 \text{ A}$ $R_{G} = 1K\Omega, V_{GE} = 15$ $T_{J} = 25^{\circ}\text{C} \text{ (see Figure 15)}$		2.2 1.2 1.2 5.0		µs µs µs mJ
$t_{r}(V_{off})$ $t_{d}(_{off})$ t_{f} E_{off} (2)	Off voltage rise time Turn-off delay time Current fall time Turn-off switching losses	$V_{CC} = 480 \text{ V, } I_{C} = 10 \text{ A}$ $R_{G} = 1K\Omega, V_{GE} = 15$ $Tj=125 \text{ °C (see Figure 15)}$		3.8 1.2 1.9 8.0		μs μs μs mJ

Eon is the tun-on losses when a typical diode is used in the test circuit in figure 2 Eon include diode recovery energy. If the IGBT is offered in a package with a co-pak diode, the co-pack diode is used as external diode. IGBTs & Diode are at the same temperature (25°C and 125°C)

Table 6. Collector-emitter diode

Symbol	Parameter	Test condictions	Min	Тур.	Max	Unit
I _f	Forward current				7	Α
I _{fm}	Forward current pulsed				56	Α
V _f	Forward on-voltage	I _f = 3.5 A I _f = 3.5 A, Tj = 125 °C		1.4 1.15	1.9	V V
t _{rr}	Reverse recovery time	$I_f = 7 \text{ A , } V_R = 20 \text{ V,}$		50		ns
Q_{rr}	Reverse recovery charge	Tj =125°C, di/dt =100A/μs		70		nC
I _{rrm}	Reverse recovery current	(see Figure 18)		2.7		Α

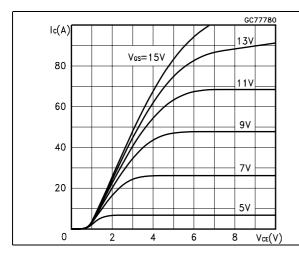
^{2.} Turn-off losses include also the tail of the collector current

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2.1 Electrical characteristics (curves)

Figure 1. Output characteristics

Figure 2. Transfer characteristics



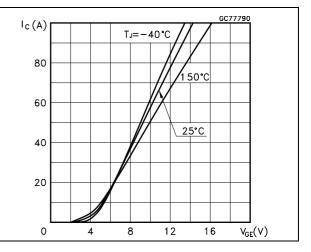
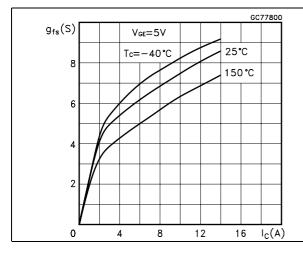


Figure 3. Transconductance

Figure 4. Collector-emitter on voltage vs temperature



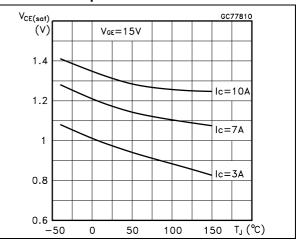
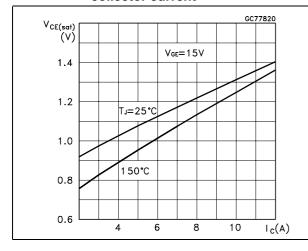
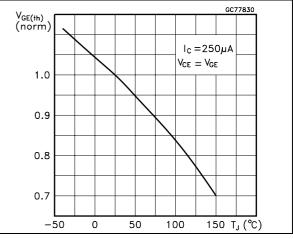


Figure 5. Collector-emitter on voltage vs collector current

Figure 6. Normalized gate threshold vs temperature





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Figure 7. Normalized breakdown voltage vs Figure 8. Gate charge vs gate-emitter voltage temperature

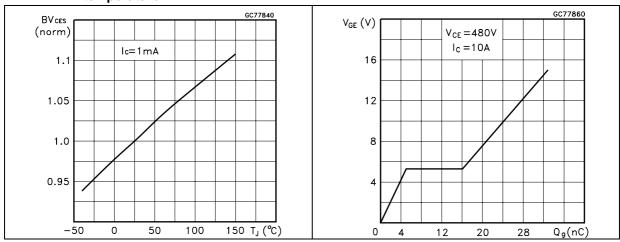


Figure 9. Capacitance variations

Figure 10. Switching losses vs temperature

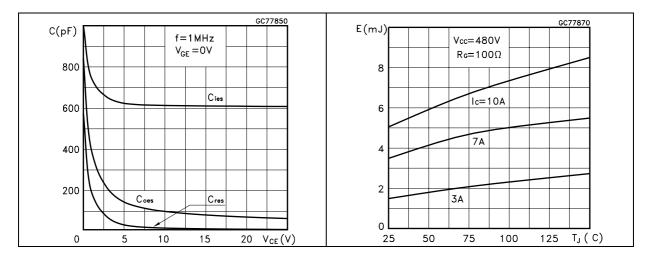
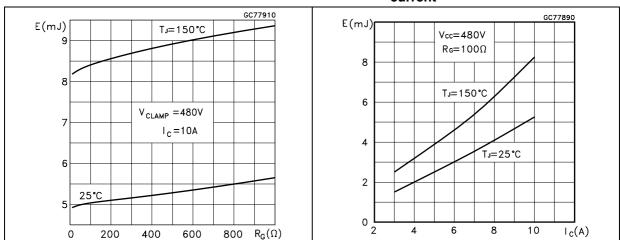


Figure 11. Switching losses vs gate resistance Figure 12. Switching losses vs collector current

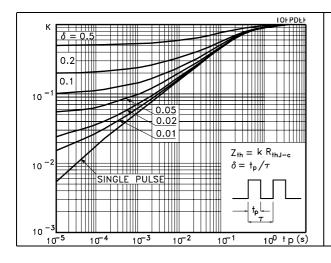


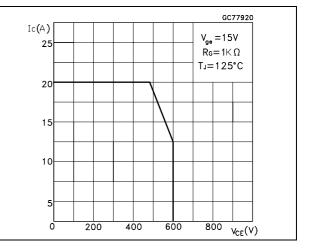
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Figure 13. Thermal impedance

Figure 14. Turn-off SOA





STGF10NB60SD Test circuit

3 Test circuit

Figure 15. Test circuit for inductive load switching

Figure 16. Gate charge test circuit

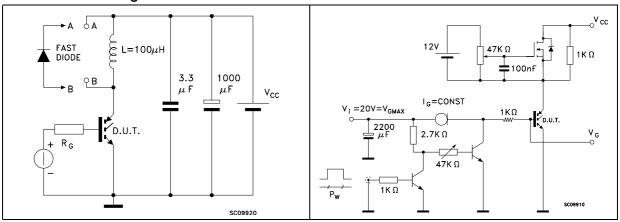
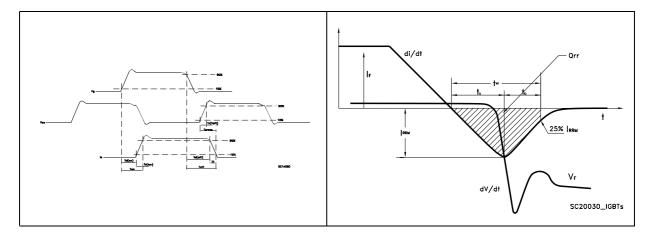


Figure 17. Switching waveforms

Figure 18. Diode recovery times waveform

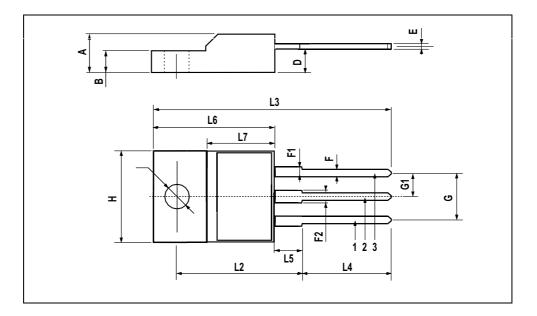


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

TO-220FP MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



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Revision history STGF10NB60SD

5 Revision history

Table 7. Revision history

Date	Revision	Changes
15-May-2006	2	New template

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